

Silicon Carbide (SiC) Cascode JFET - EliteSiC, Power N-Channel, TO247-3, 1200 V, 80 mohm

UJ3C120080K3S

Description

This SiC FET device is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si super-junction devices. Available in the TO247-3 package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads, and any application requiring standard gate drive.

Features

- Typical On-resistance $R_{DS(on),typ}$: 80 m Ω
- Maximum Operating Temperature of 175 °C
- Excellent Reverse Recovery
- Low Gate Charge
- Low Intrinsic Capacitance
- ESD Protected: HBM Class 2 and CDM Class C3
- This Device is Pb-Free, Halogen Free and is RoHS Compliant

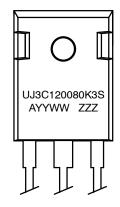
Typical Applications

- EV Charging
- PV Inverters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Motor Drives
- Induction Heating



TO247-3 15.90x20.96x5.03, 5.44P CASE 340AK

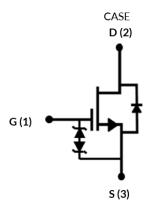
MARKING DIAGRAM



UJ3C120080K3S = Specific Device Code A = Assembly Location

YY = Year WW = Work Week ZZZ = Lot ID

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

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MAXIMUM RATINGS

Parameter	Symbol	Test Conditions	Value	Unit
Drain-source Voltage	V_{DS}		1200	V
Gate-source Voltage	V_{GS}	DC	-25 to +25	V
Continuous Drain Current (Note 1)	I _D	T _C = 25 °C	33	Α
		T _C = 100 °C	24	Α
Pulsed Drain Current (Note 2)	I _{DM}	T _C = 25 °C	77	Α
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	L = 15 mH, I _{AS} = 2.8 A	58.5	mJ
Power Dissipation	P _{tot}	T _C = 25 °C	254.2	W
Maximum Junction Temperature	$T_{J,max}$		175	°C
Operating and Storage Temperature	T _J , T _{STG}		-55 to 175	°C
Max. Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	TL		250	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited by $T_{J,max}$.

2. Pulse width t_p limited by $T_{J,max}$.

3. Starting $T_J = 25$ °C.

THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$		-	0.45	0.59	°C/W

ELECTRICAL CHARACTERISTICS (T_J = +25 °C unless otherwise specified)

Parameter	Symbol	Test Conditi	ons	Min	Тур	Max	Unit
TYPICAL PERFORMANCE - STATIC	•					•	
Drain-source Breakdown Voltage	BV _{DS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$		1200	_	-	V
Total Drain Leakage Current	I _{DSS}	$V_{DS} = 1200 \text{ V}, V_{GS} = 0$	V, T _J = 25 °C	-	10	75	μΑ
		V _{DS} = 1200 V, V _{GS} = 0	V, T _J = 175°C	-	50	-	1
Total Gate Leakage Current	I _{GSS}	V _{DS} = 0 V, T _J = 25 °C, V _{GS} = -20 V/ +20 V		-	6	±20	μΑ
Drain-source On-resistance	R _{DS(on)}	V _{GS} = 12 V, I _D = 20 A	T _J = 25 °C	-	80	100	mΩ
			T _J = 125 °C	-	130	-	
			T _J = 175 °C	-	172	-	
Gate Threshold Voltage	$V_{G(th)}$	V _{DS} = 5 V, I _D = 10 mA		4	5	6	V
Gate Resistance	R_{G}	f = 1 MHz, open drain		-	4.5	-	Ω
TYPICAL PERFORMANCE - REVERSE	DIODE						
Diode Continuous Forward Current (Note 4)	I _S	T _C = 25 °C		-	_	33	А
Diode Pulse Current (Note 5)	$I_{S,pulse}$	T _C = 25 °C		-	-	77	Α
Forward Voltage	V_{FSD}	V _{GS} = 0 V, I _S = 10 A, T _s	_J = 25 °C	-	1.5	2	V
		V _{GS} = 0 V, I _S = 10 A, T	_J = 175 °C	-	2	-	1
Reverse Recovery Charge	Q _{rr}	$V_{DS} = 800 \text{ V}, I_S = 20 \text{ A}, V_{GS} = 0 \text{ V},$		-	180	-	nC
Reverse Recovery Time	t _{rr}	$R_{G_{EXT}} = 10 \Omega$, di/dt = 1 $T_{J} = 150 ^{\circ}$ C	2200 A/μs,	-	30	-	ns

ELECTRICAL CHARACTERISTICS ($T_J = +25$ °C unless otherwise specified) (continued)

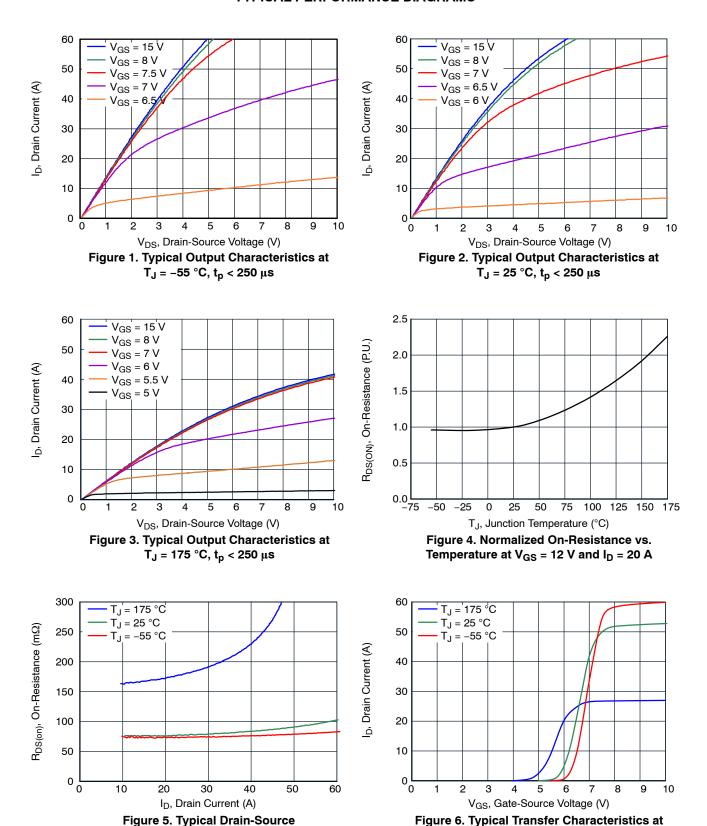
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE - DYNAMIC						
Input Capacitance	C _{iss}	V _{DS} = 100 V, V _{GS} = 0 V,	-	1500	_	pF
Output Capacitance	C _{oss}	f = 100 kHz	-	100	-	
Reverse Transfer Capacitance	C _{rss}		-	2.1	-	
Effective Output Capacitance, Energy Related	C _{oss(er)}	V _{DS} = 0 V to 800 V, V _{GS} = 0 V	-	59	-	pF
Effective Output Capacitance, Time Related	C _{oss(tr)}		-	136	_	pF
C _{oss} Stored Energy	E _{oss}	V _{DS} = 800 V, V _{GS} = 0 V	-	19	_	μJ
Total Gate Charge	Q_{G}	$V_{DS} = 800 \text{ V}, I_{D} = 20 \text{ A},$ $V_{GS} = -5 \text{ V} \text{ to } 15 \text{ V}$	-	51	-	nC
Gate-drain Charge	Q_{GD}		-	11	_	
Gate-source Charge	Q_{GS}		-	19	_	
Turn-on Delay Time	t _{d(on)}	V _{DS} = 800 V, I _D = 20 A,	-	22	-	ns
Rise Time	t _r	Gate Driver = -5 V to $+15$ V, Turn-on R _{G EXT} = 1 Ω ,	-	14	-	
Turn-off Delay Time	t _{d(off)}	Turn-off $R_{G-EXT} = 20~\Omega$, Inductive Load, FWD: UJ2D1215T, $T_{J} = 150~^{\circ}C$	-	61	-	
Fall Time	t _f		-	14	_	
Turn-on Energy	E _{ON}		-	260	-	μJ
Turn-off Energy	E _{OFF}		_	108	_	
Total Switching Energy	E _{TOTAL}	1	-	368	_	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Limited by T_{J,max}.

5. Pulse width t_p limited by T_{J,max}.

TYPICAL PERFORMANCE DIAGRAMS



 $V_{DS} = 5 V$

On-Resistances at V_{GS} = 12 V

TYPICAL PERFORMANCE DIAGRAMS (continued)

V_{GS}, Gate-Source Voltage (V)

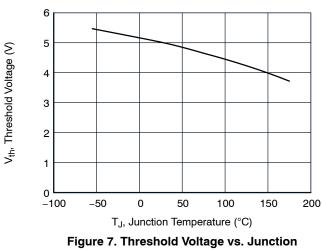


Figure 7. Threshold Voltage vs. Junction Temperature at $V_{DS} = 5 \text{ V}$ and $I_D = 10 \text{ mA}$

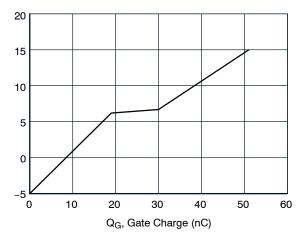


Figure 8. Typical Gate Charge at $V_{DS} = 800 \text{ V}$ and $I_{D} = 20 \text{ A}$

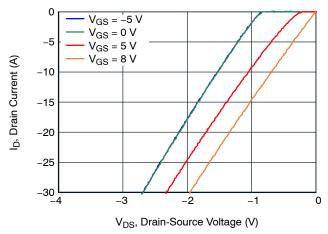


Figure 9. 3^{rd} Quadrant Characteristics at $T_J = -55$ °C

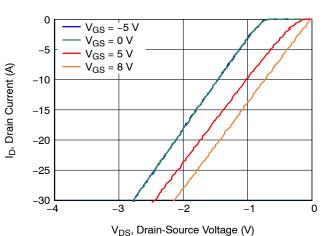


Figure 10. 3^{rd} Quadrant Characteristics at $T_J = 25$ °C

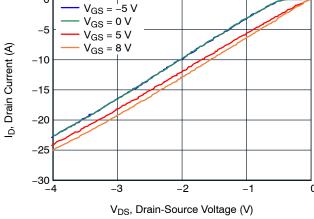


Figure 11. 3^{rd} Quadrant Characteristics at $T_J = 175$ °C

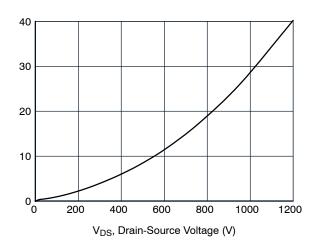


Figure 12. Typical Stored Energy in C_{OSS} at $V_{GS} = 0 \text{ V}$

Eoss (µJ)

TYPICAL PERFORMANCE DIAGRAMS (continued)

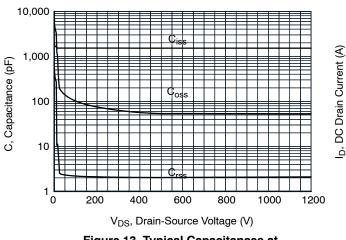


Figure 13. Typical Capacitances at f = 100 kHz and V_{GS} = 0 V

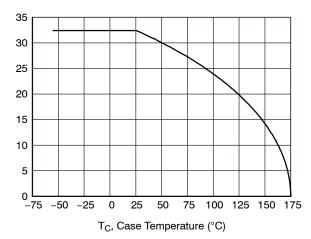


Figure 14. DC Drain Current Derating

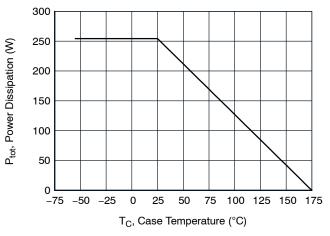


Figure 15. Total Power Dissipation

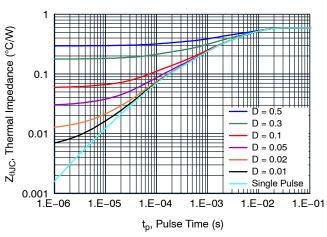


Figure 16. Maximum Transient Thermal Impedance

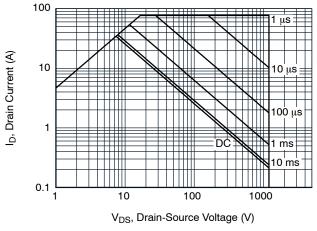


Figure 17. Safe Operation Area at $T_C = 25$ °C, D = 0, Parameter t_p

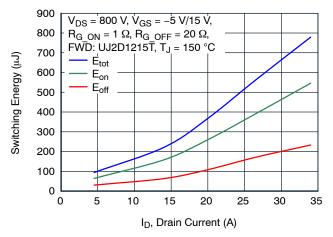


Figure 18. Clamped Inductive Switching Energy vs. Drain Current at $T_J = 150$ °C

TYPICAL PERFORMANCE DIAGRAMS (continued)

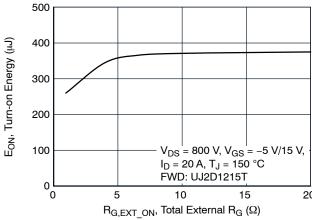


Figure 19. Clamped Inductive Switching Turn-on Energy vs. R_{G,EXT_ON}

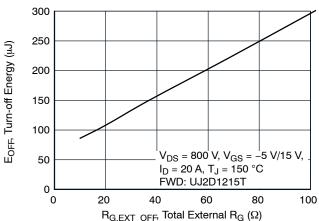


Figure 20. Clamped Inductive Switching Turn-off Energy vs. R_{G,EXT} OFF

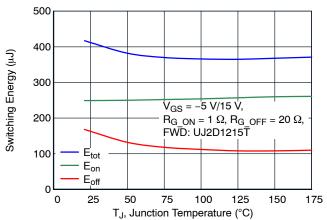


Figure 21. Clamped Inductive Switching Energy vs. Junction Temperature at V_{DS} = 800 V and I_{D} = 20 A

APPLICATIONS INFORMATION

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum

reverse recovery performance. For more information on SiC FET operation, see www.onsemi.com.

A snubber circuit with a small $R_{(G)}$, or gate resistor, provides better EMI suppression with higher efficiency compared to using a high $R_{(G)}$ value. There is no extra gate delay time when using the snubber circuitry, and a small R(G) will better control both the turn-off $V_{(DS)}$ peak spike and ringing duration, while a high $R_{(G)}$ will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high $R_{(G)}$, while greatly reducing $E_{(OFF)}$ from mid-to-full load range with only a small increase in $E_{(ON)}$. Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the **onsemi** website at www.onsemi.com.

ORDERING INFORMATION

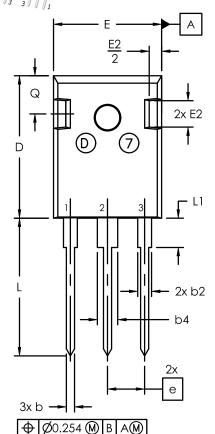
Part Number	Marking	Package	Shipping
UJ3C120080K3S	UJ3C120080K3S	TO247-3 15.90x20.96x5.03, 5.44P (Pb-Free, Halogen Free)	600 / Tube

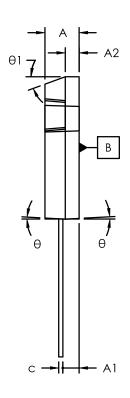


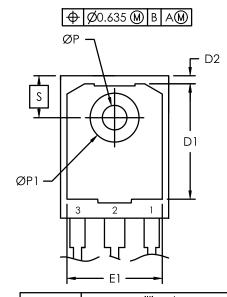


TO247-3 15.90x20.96x5.03, 5.44P CASE 340AK ISSUE B

DATE 14 APR 2025







SYM	millimeters				
317/1	MIN	NOM	MAX		
Α	4.70	5.03	5.31		
A1	2.21	2.40	2.59		
A2	1.50	2.03	2.49		
b	0.99	1.20	1.40		
b2	1.65	2.03	2.39		
b4	2.59	3.00	3.43		
ОД	0.38	0.60	0.89		
D	20.70	20.96	21.46		
D1	13.08	ı	ı		
D2	0.51	1.19	1.35		
Е	15.49	15.90	16.26		
е		5.44 BSC			
E1	13.00	13.30	13.60		
E2	3.43	3.89	5.20		
L	19.62	20.27	20.32		
L1	ı	ı	4.50		
ØP	3.40	3.60	3.80		
ØP1	7.06	7.19	7.39		
Q	5.38	5.62	6.20		
S	6.15 BSC				
Φ	3°				
θ1	20°				
θ2	10°				

θ2

NOTE:

- 1. Dimensioning and tolerancing as per ASME Y14.5 2018
- 2. Controlling dimension: millimeters
- 3. Package Outline in compliance with JEDEC standard var. AD.
- 4. Dimensions D & E does not include mold flash.
- 5. ØP to have max draft angle of 1.7° to the top with max. hole diameter of 3.91mm.

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DESCRIPTION:	TO247-3 15.90x20.96x5.03	TO247-3 15.90x20.96x5.03, 5.44P	

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